

## DIM200MKS12-A000

# **IGBT Chopper Module**

Replaces November 2002, issue DS5552-1.2

DS5552-1.2 November 2002

#### **FEATURES**

- 10us Short Circuit Withstand
- Non Punch Through Silicon
- Isolated Copper Baseplate

### **APPLICATIONS**

- Choppers
- Motor Controllers
- Induction Heating
- Resonant Converters
- Power Supplies

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 600V to 3300V and currents up to 2400A.

The DIM200MKS12-A000 is a 1200V, n channel enhancement mode, insulated gate bipolar transistor (IGBT) chopper module configured with the upper arm of the bridge controlled. The module incorporates a high current rated freewheel diode. The IGBT has a wide reverse bias safe operating area (RBSOA) plus full  $10\mu s$  short circuit withstand.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

#### **ORDERING INFORMATION**

Order As:

#### DIM200MKS12-A000

Note: When ordering, please use the whole part number.

## **KEY PARAMETERS**

$V_{CES}$		1200V
V <sub>CE(sat)</sub> *	(typ)	2.2V
	(max)	200A
I <sub>C(PK)</sub>	(max)	400A

\*(measured at the power busbars and not the auxiliary terminals)

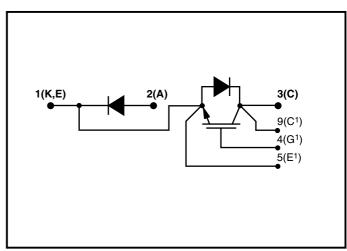


Fig. 1 Chopper circuit diagram - upper arm controlled

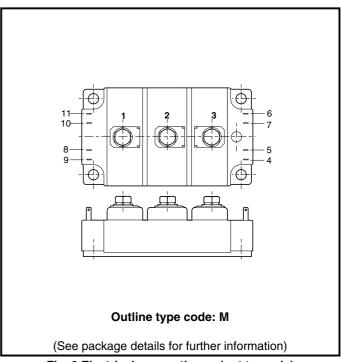


Fig. 2 Electrical connections - (not to scale)



#### **ABSOLUTE MAXIMUM RATINGS - PER ARM**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V$	1200	V
V <sub>GES</sub>	Gate-emitter voltage	-	±20	٧
I <sub>c</sub>	Continuous collector current	$T_{\text{case}} = 80^{\circ}\text{C}$	200	Α
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 115°C	400	Α
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	1435	W
l²t	Diode I <sup>2</sup> t value	$V_R = 0, t_p = 10 \text{ms}, T_{vj} = 125^{\circ}\text{C}$	6.25	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage - per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2500	V
$Q_{PD}$	Partial discharge - per module	IEC1287. V <sub>1</sub> = 1300V, V <sub>2</sub> = 1000V, 50Hz RMS	10	PC



## THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
R <sub>th(j-c)</sub>	Thermal resistance - transistor (per arm)	Continuous dissipation -	-	-	87	°C/kW
		junction to case				
R <sub>th(j-c)</sub>	Thermal resistance - diode (per arm)	Continuous dissipation -	-	-	194	°C/kW
	(Antiparallel and freewheel diode)	junction to case				
R <sub>th(c-h)</sub>	Thermal resistance - case to heatsink	Mounting torque 5Nm	-	-	15	°C/kW
	(per module)	(with mounting grease)				
T <sub>j</sub>	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T <sub>stg</sub>	Storage temperature range	-	-40	-	125	°C
-	Screw torque	Mounting - M6	-	-	5	Nm
		Electrical connections - M4	-	-	2	Nm



#### **ELECTRICAL CHARACTERISTICS**

 $T_{case} = 25$ °C unless stated otherwise.

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}$		-	-	0.25	mA
		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 125$	s°C	-	-	6	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V$ , $V_{CE} = 0V$		-	-	1	μА
V <sub>GE(TH)</sub>	Gate threshold voltage	$I_{\rm C} = 10 {\rm mA}, \ V_{\rm GE} = V_{\rm CE}$		4.5	5.5	6.5	V
V <sub>CE(sat)</sub> †	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 200A		-	2.2	2.7	V
		$V_{GE} = 15V, I_{C} = 200A, , T_{case} = 12$	25°C	-	2.6	3.1	V
I <sub>F</sub>	Diode forward current	DC		-	-	200	Α
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms		-	-	400	А
V <sub>F</sub> <sup>†</sup>	Diode forward voltage	I <sub>F</sub> = 200A		-	2.1	2.4	V
	(Antiparallel and freewheel diode)	I <sub>F</sub> = 200A, T <sub>case</sub> = 125°C		-	2.1	2.4	V
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		-	23	-	nF
L <sub>M</sub>	Module inductance - per arm	-		-	30	-	nH
R <sub>INT</sub>	Internal transistor resistance - per arm	-		-	0.27	-	mΩ
SC <sub>Data</sub>	Short circuit. I <sub>SC</sub>	$T_{j} = 125^{\circ}C, V_{CC} = 900V,$	I <sub>1</sub>	-	1375	-	Α
		$t_p \le 10\mu s$ , $V_{CE(max)} = V_{CES} - L^*$ . di/dt	l <sub>2</sub>	-	1125	-	А
		IEC 60747-9					

#### Note:

<sup>&</sup>lt;sup>†</sup> Measured at the power busbars and not the auxiliary terminals)

 $L^*$  is the circuit inductance +  $L_{\rm M}$ 



## **ELECTRICAL CHARACTERISTICS**

 $T_{case} = 25$ °C unless stated otherwise

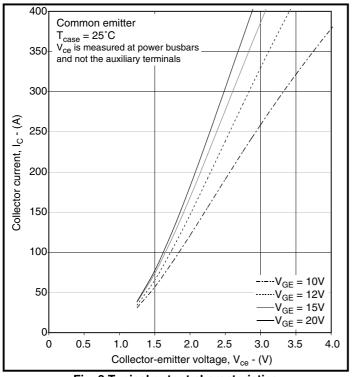
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 200A	-	600	-	ns
t <sub>f</sub>	Fall time	V <sub>GE</sub> = ±15V	-	50	-	ns
E <sub>OFF</sub>	Turn-off energy loss	V <sub>CE</sub> = 600V	-	20	-	mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 4.7\Omega$	-	240	-	ns
t <sub>r</sub>	Rise time	L ~ 100nH	-	95	-	ns
E <sub>on</sub>	Turn-on energy loss		-	25	-	mJ
$Q_g$	Gate charge		-	2	-	μС
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 200A, V <sub>R</sub> = 600V,	-	30	-	μС
I <sub>rr</sub>	Diode reverse current	dl <sub>F</sub> /dt = 2100A/μs	-	125	-	А
E <sub>REC</sub>	Diode reverse recovery energy		-	13	-	mJ

# $T_{case} = 125$ °C unless stated otherwise

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>c</sub> = 200A	-	800	-	ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$	-	70	-	ns
E <sub>OFF</sub>	Turn-off energy loss	V <sub>CE</sub> = 600V	-	27	-	mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 4.7\Omega$	-	385	-	ns
t <sub>r</sub>	Rise time	L ~ 100nH	-	110	-	ns
E <sub>on</sub>	Turn-on energy loss		-	40	-	mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 200A, V <sub>R</sub> = 600V,	-	50	-	μC
I <sub>rr</sub>	Diode reverse current	dI <sub>ε</sub> /dt = 1900A/μs	-	140	-	Α
E <sub>REC</sub>	Diode reverse recovery energy		-	20	-	mJ



#### **TYPICAL CHARACTERISTICS**



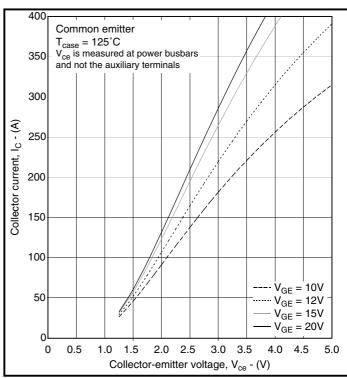
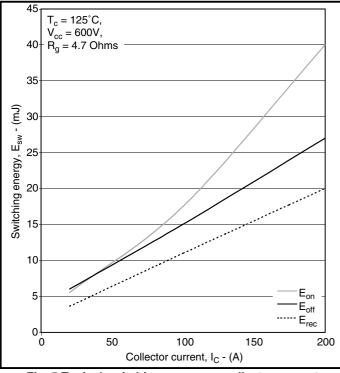
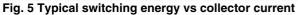


Fig. 3 Typical output characteristics







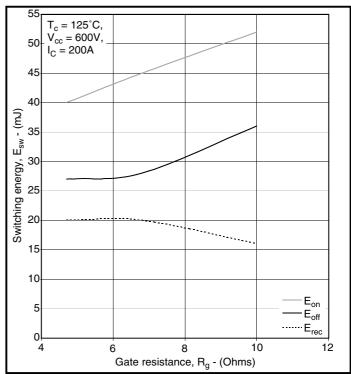
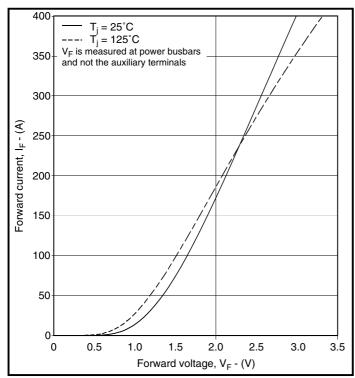


Fig. 6 Typical switching energy vs gate resistance

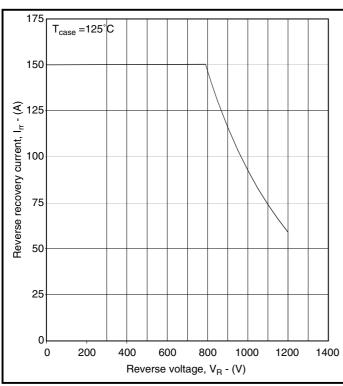


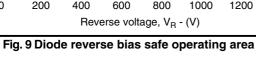


Module I<sub>C</sub> Chip  $I_{\mathbb{C}}$ 400 350 Collector current, I<sub>C</sub> - (A) 250 250 150 100 50  $T_{case} = 125^{\circ}C$   $V_{ge} = 15V$   $R_g = 4.7 \text{ Ohms}$ 200 600 800 1000 1200 1400 400 Collector emitter voltage,  $V_{ce}$  - (V)

Fig. 7 Diode typical forward characteristics

Fig. 8 Reverse bias safe operating area





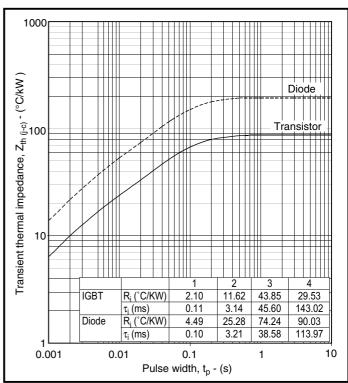


Fig. 10 Transient thermal impedance



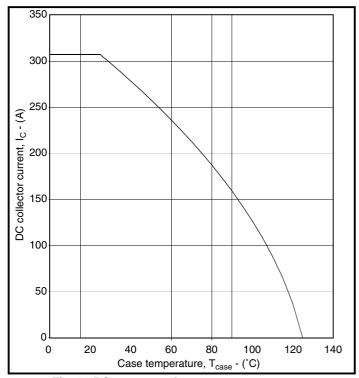
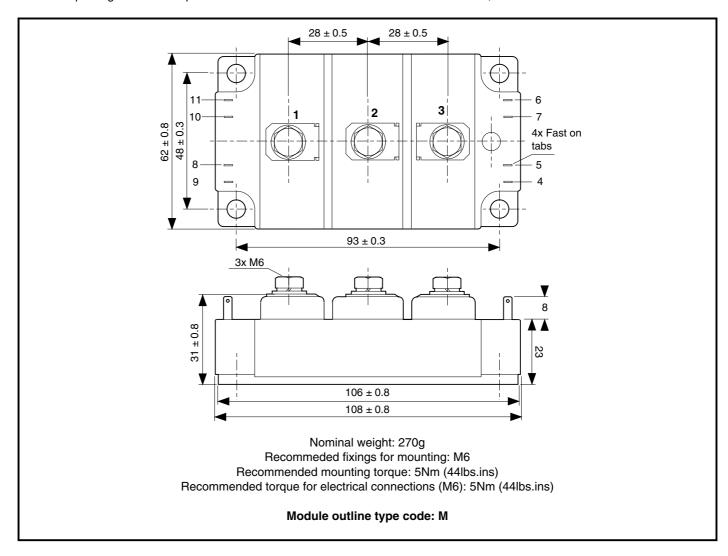


Fig. 11 DC current rating vs case temperature



#### **PACKAGE DETAILS**

For further package information please contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.





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We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

#### **HEATSINKS**

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.



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